Synthesis characterization and dielectric properties of a new cation-deficient perovskite Ba₄La₂Ti₃Nb₂O₁₈

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Recent progress in microwave telecommunication and satellite broadcasting has demanded the need for good quality ceramic dielectric resonators (DR). The important characteristics required for a DR are high dielectric constant (ε_r) for miniaturization, high quality factor (Q) for selectivity and low temperature coefficient of resonant frequency (τ_f) for stability. Several DR materials such as Ba(Zn_{1/3}Ta_{2/3})O₃, Ba₂Ti₉O₂₀, BaTi₄O₉, (Zr,Sn)TiO₄, and Ba_{6-3x}Re_{8+2x}Ti₁₈O₅₄ (Re = Nd, Sm) system have been investigated for practical application [1, 2]. Still, the search for new materials having those properties is in rapid progress [3–8]. Recently, the microwave dielectric properties of some $A_5B_4O_{15}$ type cation-deficient hexagonal perovskites such as $Ba_5Nb_4O_{15}$, $Ba_{5-x}Sr_xNb_4O_{15}$, $Ba_5Ta_4O_{15}$, $ALa_4Ti_4O_{15}(A = Ca, Sr and Ba)$ have attracted much attention [9–15], while only two $A_6B_5O_{18}$ type perovskites $A_2La_4Ti_5O_{18}$ (A = Ca, Ba) so far have been reported [11–13]. Both ceramics are characterized by high dielectric constant up to 50.6, high quality factors with $Q \times f$ up to 31 839 GHz, and low $\tau_{\rm f}$ in the range -36.4 to +6 ppm °C⁻¹ [11, 13]. It is worthwhile to investigate whether other $A_6B_5O_{18}$ perovskites might have equivalent or superior properties. In the present paper, we report the synthesis, characterization and dielectric properties of a new $A_6B_5O_{18}$ type cation-deficient perovskite Ba₄La₂Ti₃Nb₂O₁₈, for the first time.

Polycrystalline sample of $Ba_4La_2Ti_3Nb_2O_{18}$ was prepared using high temperature solid-state reaction techniques. The stoichiometric mixtures of the high purity powders of $BaCO_3$ (99.9%), La_2O_3 (99.99%), TiO_2 (>99.95%) and Nb_2O_5 (99.9%), were weighed and ball milled in distilled water medium for 12 hrs in a plastic bottle using zirconia balls. The wet mixture was dried and calcined in the range 1200 °C for 4 hrs, then ground and again calcined at 1400 °C for 4 hrs. The calcined powders were thoroughly reground and mixed with 5% solution of polyvinyl alcohol (PVA) as a binder. The slurry was then dried, ground and then pressed into cylindrical disks of different thickness in the range 5–7 and 11 mm in diameter under a pressure of 180 MPa. The green compacts were initially fired at a rate of 3 °C/min up to 600 °C and then at a rate of 12 °C/min to the sintering temperature. An intermediate soaking at 600 °C for 2 hrs was given to expel the binder. The optimized sintering temperature was 1465 °C for Ba₄La₂Ti₃Nb₂O₁₈. The sintering was carried out for a duration of 4 hrs. The sintered sample was typically annealed at 1400 °C for 6 hrs to minimize the reduction of titanium ions.

The density of the ceramic was measured by the Archimedes method. The phase identification and microstructure characterization were done using a Rigaku D/MAX-RB powder X-ray diffractometer (XRD) using Cu K_{α} radiation ($\lambda = 0.154$ –0.6 nm) in a 2 θ range from 10 to 80° and using a Jeol JSM-5610LV scanning electron microscope (SEM). Thin discs of about 2 mm thickness were used as a capacitor to determine the dielectric constant ε_r at low frequency (1 kHz to 1 MHz) using an HP4284A LCR meter at room temperature. Silver paste was applied to the surfaces of these discs, then dried at 600 °C for 30 min and cooled naturally to room temperature. The microwave dielectric properties such as dielectric constant and unloaded $Q(Q_u)$ factor were measured using an Agilent 8722ET network analyzer; the dielectric constant was calculated using TE_{011} mode under the end-shorted condition using the method suggested by Hakki and Coleman and modified by Courtney [16, 17]. The $\tau_{\rm f}$ was measured by noting the temperature variation of the TE_{011} resonance in the temperature range 15–85 °C.

The room temperature XRD pattern recorded for the ceramics using $\text{Cu} \text{K}_{\alpha}$ radiation is shown in Fig. 1. The pattern is similar and matches with the one reported for Ba₂La₄Ti₅O₁₈ by Saltykova *et al.* (JCPDS file No. 38-1039) [18]. All peaks found were indexed and there was no evidence of any second phases(s) present, therefore, the ceramic is single-phase pure. The

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Figure 1 XRD pattern of Ba₄La₂Ti₃Nb₂O₁₈.

compound crystallizes in the trigonal system with unit cell parameters a = 5.6647(1) Å; c = 41.8629(7) Å, V = 1163.36(3) Å³ and Z = 3, refined by the leastsquares method. The compound belongs to $A_6B_5O_{18}$ perovskite-related structure where the Ba and La ions occupy the A sites with coordination numbers of 12, and Nb and Ti ions occupy the B sites with coordination numbers of 6. The crystal structure can be described as consisting of identical perovskite-like blocks, five corner-sharing BO₆ octahedra thick, separated by vacant octahedral layers [19, 20].

The Ba₅LaTi₂Nb₃O₁₈ ceramic was sintered into a dense body, and the relative density is 94.2% of its theoretical density. Fig. 2 shows the SEM micrograph of the fracture surface of the ceramic. The microstructure indicates a monophase constitution with packed hexagonal grains in the size range 4–10 μ m.

The dielectric constant (ε_r) of the Ba₄La₂Ti₃Nb₂O₁₈ ceramic in the 1 kHz–1 MHz region is shown in Fig. 3 as a function of the frequency. The ε_r of Ba₄La₂Ti₃Nb₂O₁₈ ceramic decreases from 61.45 to 55.23 with increasing frequency from 1 kHz to 1 MHz due to the reduction of active polarization mechanism. The microwave dielectric properties were measured under TE₀₁₁ mode. The Ba₄La₂Ti₃Nb₂O₁₈ ceramic shows an ε_r of 54.73 calculated from the TE₀₁₁ resonance, and a high quality factor with Q_u of 3775 GHz at 4.7210 GHz. The dielectric constant at microwave frequency is in good agreement with the value obtained at 1 MHz, which is higher than



Figure 3 Variation of the dielectric constant with frequency for $Ba_4La_2Ti_3Nb_2O_{18}$.

those of $Ba_2La_4Ti_5O_{18}$ (46) and $Ca_2La_4Ti_5O_{18}$ (44.7) [11, 13].

The dielectric constant can be calculated from the Clausius-Mossotti equation:

$$\varepsilon_{\rm r} = \frac{3V_{\rm m} + 8\pi\alpha_{\rm D}^{\rm T}}{3V_{\rm m} - 4\pi\alpha_{\rm D}^{\rm T}} \tag{1}$$

where $V_{\rm m}$ is the molar volume and $\alpha_{\rm D}^{\rm T}$ is the sum of ionic polarizabilities of individual ions given by Shannon [21]. The calculated dielectric constants usually agree well with the experimental values for well-behaved ceramics [21]. However, an inconsistency is found when the equation is applied to the La containing $A_n B_{n-1} O_{3n}$ compounds such as BaLa₄Ti₄O₁₅ and Ba₂La₄Ti₅O₁₈ [11, 13]. It has been suggested by Veneis et al. that if the ionic polarizability of the La ion (α_{La}) is changed to 4.82 instead of 6.07 given by Shannon, the inconsistency can be avoided [11]. Using $\alpha_{La} = 4.82$, the dielectric constant of Ba₄La₂Ti₃Nb₂O₁₈ is calculated as 60.73, which is in good agreement with the experimental values of 59.78 corrected for porosity using Rushman and Strivens equation [22] $\varepsilon_{\text{corr}} = \varepsilon_{\text{obs}}(2+V_2)/(2-2V_2)$, where V_2 is the volume fraction of porosity in the sintered compact. The small difference is due to deviations from the cubic symmetry and also the fact that the sample is a ceramic and not a single crystal [13].

Fig. 4 shows the variation of resonant frequencies in the TE_{011} mode of $Ba_4La_2Ti_3Nb_2O_{18}$ ceramics as



Figure 2 SEM micrograph of Ba₄La₂Ti₃Nb₂O₁₈.



Figure 4 Variation of resonant frequency of $Ba_4La_2Ti_3Nb_2O_{18}$ as a function of the temperature.

a function of the temperature. The temperature coefficient of the resonant frequency τ_f is calculated using the equation:

$$\tau_{\rm f} = \frac{1}{f} \cdot \frac{\Delta f}{\Delta T} \tag{2}$$

The τ_f of Ba₄La₂Ti₃Nb₂O₁₈ ceramic is +65 ppm °C⁻¹, which is relatively higher compared to those of Ba₂La₄Ti₅O₁₈ (-36.4 ppm °C⁻¹) and Ca₂La₄Ti₅O₁₈ (+6 ppm °C⁻¹) [11, 13].

A new dielectric ceramic Ba₄La₂Ti₃Nb₂O₁₈ has been prepared and characterized. The compound adopts a cation-deficient trigonal A₆B₅O₁₈ perovskite structure. It has a high dielectric constant of 54.7, a high quality factor with $Q \times f$ of 17,821 GHz, and a positive τ_f of +65 ppm °C⁻¹. Although the ε_r and Q_u of the ceramic are encouraging, its relatively high τ_f precludes their use as dielectric resonators for practical applications. However, through appropriated substitution or the use of additives, it may be possible to obtain a nearly temperature compensated dielectric.

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